# High-Bandwidth, Low Voltage, Dual SPDT Analog Switches 

## DESCRIPTION

The DG2016/DG2026 are monolithic CMOS dual single-pole/double-throw (SPDT) analog switchs. They are specifically designed for low-voltage, high bandwidth applications.
The DG2016/DG2026's on-resistance ( $3 \Omega$ at 2.7 V ), matching and flatness are guaranteed over the entire analog voltage range. Wide dynamic performance is achieved with better than - 80 dB for both cross-talk and off-isolation at 1 MHz .
Both SPDT's operate with independent control logic, conduct equally well in both directions and block signals up to the power supply level when off. Break-before-make is guaranteed.
With fast switching speeds, low on-resistance, high bandwidth, and low charge injection, the DG2016/DG2026 are ideally suited for audio and video switching with high linearity.
Built on Vishay Siliconix's low voltage CMOS technology, the DG2016/DG2026 contain an epitaxial layer which prevents latch-up.

## FEATURES

- Single Supply (1.8 V to 5.5 V )
- Low On-Resistance - ron: $2.4 \Omega$
- Crosstalk and Off Isolation: - 81 dB at 1 MHz
- MSOP-10 Package



## BENEFITS

- Reduced Power Consumption
- High Accuracy
- Reduce Board Space
- Low-Voltage Logic Compatible
- High Bandwidth


## APPLICATIONS

- Cellular Phones
- Speaker Headset Switching
- Audio and Video Signal Routing
- PCMCIA Cards
- Low-Voltage Data Acquisition
- ATE


## FUNCTIONAL BLOCK DIAGRAM AND PIN CONFIGURATION



| TRUTH TABLE |  |  |
| :---: | :---: | :---: |
| Logic | NC1 and NC2 | NO1 and NO2 |
| 0 | ON | OFF |
| 1 | OFF | ON |


| ORDERING INFORMATION |  |  |
| :---: | :---: | :---: |
| Temp Range | Package | Part Number |
| -40 to $85^{\circ} \mathrm{C}$ | MSOP-10 | DG2016DQ-T1-E3 |
|  |  | DG2026DQ-T1-E3 |

## Vishay Siliconix

| ABSOLUTE MAXIMUM RATINGS | Limit | Unit |
| :--- | :---: | :---: | :---: |
| Parameter | -0.3 to +6 |  |
| Reference $\mathrm{V}+$ to GND | -0.3 to $(\mathrm{V}++0.3)$ |  |
| $\mathrm{IN}, \mathrm{COM}, \mathrm{NC}, \mathrm{NO}^{\mathrm{a}}$ | $\pm 50$ | mA |
| Continuous Current (Any terminal) | $\pm 200$ |  |
| Peak Current (Pulsed at $1 \mathrm{~ms}, 10 \%$ duty cycle) | -65 to 150 | ${ }^{\circ} \mathrm{C}$ |
| Storage Temperature (D Suffix) | 320 | mW |
| Power Dissipation (Packages) ${ }^{\mathrm{b}}$ | MSOP-10 |  |

## Notes:

a. Signals on NC, NO, or COM or IN exceeding V+ will be clamped by internal diodes. Limit forward diode current to maximum current ratings.
b. All leads welded or soldered to PC Board.
c. Derate $4.0 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ above $70{ }^{\circ} \mathrm{C}$.

| SPECIFICATIONS (V+ = 3 V) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Parameter | Symbol | Test Conditions Otherwise Unless Specified$\mathrm{V}+=3 \mathrm{~V}, \pm 10 \%, \mathrm{~V}_{\mathrm{IN}}=0.4 \text { or } 2.0 \mathrm{Ve}$ | Temp ${ }^{\text {a }}$ | $\begin{gathered} \text { Limits } \\ -40 \text { to } 85^{\circ} \mathrm{C} \end{gathered}$ |  |  | Unit |
|  |  |  |  | Min ${ }^{\text {b }}$ | Typ ${ }^{\text {c }}$ | Max ${ }^{\text {b }}$ |  |
| Analog Switch |  |  |  |  |  |  |  |
| Analog Signal Range ${ }^{\text {d }}$ | $\mathrm{V}_{\mathrm{NO}}, \mathrm{V}_{\mathrm{NC}}$ $V_{\text {COM }}$ |  | Full | 0 |  | V+ | V |
| On-Resistance | $\mathrm{r}_{\mathrm{ON}}$ | $\mathrm{V}+=2.7 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=0.2 \mathrm{~V} / 1.5 \mathrm{~V}, \mathrm{I}_{\mathrm{NO}}, \mathrm{I}_{\mathrm{NC}}=10 \mathrm{~mA}$ | $\begin{gathered} \text { Room } \\ \text { Full } \end{gathered}$ |  | 3.0 | $\begin{aligned} & 4.8 \\ & 5.3 \end{aligned}$ | O |
| $\mathrm{r}_{\text {ON }}$ Flatness | ron Flatness | $\mathrm{V}+=2.7 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=0$ to $\mathrm{V}+\mathrm{I}_{\mathrm{NO}}, \mathrm{I}_{\mathrm{NC}}=10 \mathrm{~mA}$ | Room |  |  | 1.6 |  |
| Switch Off <br> Leakage Current ${ }^{\text {f }}$ | ${ }^{\mathrm{N} O}$ (off) $\mathrm{I}_{\mathrm{NC} \text { (off) }}$ | $\begin{gathered} \mathrm{V}_{+}=3.3 \mathrm{~V} \\ \mathrm{~V}_{\mathrm{NO}}, \mathrm{~V}_{\mathrm{NC}}=0.3 \mathrm{~V} / 3 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=3 \mathrm{~V} / 0.3 \mathrm{~V} \end{gathered}$ | Room Full | $\begin{gathered} \hline-1 \\ -10 \end{gathered}$ |  | $\begin{gathered} \hline 1 \\ 10 \end{gathered}$ | nA |
|  | $\mathrm{I}_{\text {com(off) }}$ |  | Room Full | $\begin{gathered} -1 \\ -10 \end{gathered}$ |  | $\begin{gathered} \hline 1 \\ 10 \end{gathered}$ |  |
| Channel-On Leakage Current ${ }^{\dagger}$ | $\mathrm{I}_{\text {COM(on) }}$ | $\mathrm{V}+=3.3 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}, \mathrm{V}_{\mathrm{NC}}=\mathrm{V}_{\mathrm{COM}}=0.3 \mathrm{~V} / 3 \mathrm{~V}$ | Room Full | $\begin{gathered} -1 \\ -10 \end{gathered}$ |  | $\begin{gathered} 1 \\ 10 \end{gathered}$ |  |
| Digital Control |  |  |  |  |  |  |  |
| Input High Voltage ${ }^{\text {d }}$ | $\mathrm{V}_{\text {INH }}$ |  | Full | 1.6 |  |  | V |
| Input Low Voltage | $\mathrm{V}_{\text {INL }}$ |  | Full |  |  | 0.4 |  |
| Input Capacitance | $\mathrm{C}_{\text {in }}$ |  | Full |  | 5 |  | pF |
| Input Current | $\mathrm{I}_{\text {INL }}$ or $\mathrm{I}_{\text {INH }}$ | $\mathrm{V}_{\text {IN }}=0$ or $\mathrm{V}+$ | Full | 1 |  | 1 | $\mu \mathrm{A}$ |
| Dynamic Characteristics |  |  |  |  |  |  |  |
| Turn-On Time | $\mathrm{t}_{\mathrm{ON}}$ | $\mathrm{V}_{\mathrm{NO}}$ or $\mathrm{V}_{\mathrm{NC}}=2.0 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}$ | Room Full |  | 28 | $\begin{aligned} & 53 \\ & 59 \end{aligned}$ | ns |
| Turn-Off Time | $\mathrm{t}_{\text {OFF }}$ |  | Room |  | 13 | $\begin{aligned} & 38 \\ & 38 \end{aligned}$ |  |
| Break-Before-Make Time | $\mathrm{t}_{\mathrm{d}}$ |  | Full | 1 |  |  |  |
| Charge Injection ${ }^{\text {d }}$ | $\mathrm{Q}_{\text {INJ }}$ | $\mathrm{C}_{\mathrm{L}}=1 \mathrm{nF}, \mathrm{V}_{\mathrm{GEN}}=0 \mathrm{~V}, \mathrm{R}_{\mathrm{GEN}}=0 \Omega$ | Room |  | 38 |  | pC |
| Off-Isolation ${ }^{\text {d }}$ | OIRR | $R_{L}=50 \Omega, C_{L}=5 \mathrm{pF}, \mathrm{f}=1 \mathrm{MHz}$ | Room |  | -78 |  | dB |
| Crosstalk ${ }^{\text {d }}$ | $\mathrm{X}_{\text {TALK }}$ |  | Room |  | -82 |  |  |
| $\mathrm{N}_{\mathrm{O}}, \mathrm{N}_{\mathrm{C}}$ Off Capacitance ${ }^{\text {d }}$ | $\mathrm{C}_{\mathrm{NO} \text { (off) }}$ | $\mathrm{V}_{\text {IN }}=0$ or $\mathrm{V}+$, $\mathrm{f}=1 \mathrm{MHz}$ | Room |  | 15 |  | pF |
|  | $\mathrm{C}_{\mathrm{NC} \text { (off) }}$ |  | Room |  | 15 |  |  |
| Channel-On Capacitance ${ }^{\text {d }}$ | $\mathrm{C}_{\mathrm{NO} \text { (on) }}$ |  | Room |  | 49 |  |  |
|  | $\mathrm{C}_{\mathrm{NC} \text { (on) }}$ |  | Room |  | 45 |  |  |
| Power Supply |  |  |  |  |  |  |  |
| Power Supply Current | $1+$ | $\mathrm{V}_{\text {IN }}=0$ or $\mathrm{V}^{+}$ | Full |  | 0.01 | 1.0 | $\mu \mathrm{A}$ |


| SPECIFICATIONS (V+ = 5 V ) |  |  |  |  |  |  |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Parameter | Symbol | Test Conditions Otherwise Unless Specified$\mathrm{V}_{+}=5 \mathrm{~V}, \pm 10 \%, \mathrm{~V}_{\mathrm{IN}}=0.8 \text { or } 2.4 \mathrm{~V}^{\mathrm{e}}$ | Temp ${ }^{\text {a }}$ | $\begin{gathered} \text { Limits } \\ -40 \text { to } 85^{\circ} \mathrm{C} \end{gathered}$ |  |  | Unit |
|  |  |  |  | Min ${ }^{\text {b }}$ | Typ ${ }^{\text {c }}$ | Max ${ }^{\text {b }}$ |  |
| Analog Switch |  |  |  |  |  |  |  |
| Analog Signal Range ${ }^{\text {d }}$ | $\begin{gathered} \mathrm{V}_{\mathrm{NO}}, \mathrm{~V}_{\mathrm{NC}} \\ \mathrm{~V}_{\mathrm{COM}} \end{gathered}$ |  | Full | 0 |  | V+ | V |
| On-Resistance | ${ }^{\text {ron }}$ | $\mathrm{V}+=4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=3 \mathrm{~V}, \mathrm{I}_{\mathrm{NO}}, \mathrm{I}_{\mathrm{NC}}=10 \mathrm{~mA}$ | $\begin{gathered} \text { Room } \\ \text { Full } \end{gathered}$ |  | 2.4 | $\begin{aligned} & 4.0 \\ & 4.3 \\ & \hline \end{aligned}$ | Q |
| $\mathrm{r}_{\text {ON }}$ Flatness | ron Flatness | $\mathrm{V}+=4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=0$ to $\mathrm{V}+, \mathrm{I}_{\mathrm{NO}}, \mathrm{I}_{\mathrm{NC}}=10 \mathrm{~mA}$ | Room |  |  | 1.2 |  |
| Switch Off <br> Leakage Current | $\mathrm{I}_{\mathrm{NO} \text { (off) }}$ $\mathrm{I}_{\mathrm{NC} \text { (off) }}$ | $\begin{gathered} \mathrm{V}_{+}=5.5 \mathrm{~V} \\ \mathrm{~V}_{\mathrm{NO}}, \mathrm{~V}_{\mathrm{NC}}=1 \mathrm{~V} / 4.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{COM}}=4.5 \mathrm{~V} / 1 \mathrm{~V} \end{gathered}$ | Room Full | $\begin{gathered} -1 \\ -10 \end{gathered}$ |  | 1 10 | nA |
|  | ${ }^{\text {Com(off) }}$ |  | Room Full | $\begin{gathered} -1 \\ -10 \end{gathered}$ |  | 1 10 |  |
| Channel-On Leakage Current | $\mathrm{I}_{\text {COM(on) }}$ | $\mathrm{V}_{+}=5.5 \mathrm{~V}, \mathrm{~V}_{\mathrm{NO}}, \mathrm{V}_{\mathrm{NC}}=\mathrm{V}_{\mathrm{COM}}=1 \mathrm{~V} / 4.5 \mathrm{~V}$ | Room Full | $\begin{array}{r} -1 \\ -10 \\ \hline \end{array}$ |  | 1 10 |  |
| Digital Control |  |  |  |  |  |  |  |
| Input High Voltage ${ }^{\text {d }}$ | $\mathrm{V}_{\text {INH }}$ |  | Full | 2.0 |  |  |  |
| Input Low Voltage | $\mathrm{V}_{\text {INL }}$ |  | Full |  |  | 0.8 |  |
| Input Capacitance | $\mathrm{C}_{\text {in }}$ |  | Full |  | 5 |  | pF |
| Input Current | $\mathrm{I}_{\text {INL }}$ or $\mathrm{I}_{\text {INH }}$ | $\mathrm{V}_{\text {IN }}=0$ or $\mathrm{V}_{+}$ | Full | 1 |  | 1 | $\mu \mathrm{A}$ |
| Dynamic Characteristics |  |  |  |  |  |  |  |
| Turn-On Time | $\mathrm{t}_{\mathrm{ON}}$ | $\mathrm{V}_{\mathrm{NO}}$ or $\mathrm{V}_{\mathrm{NC}}=3 \mathrm{~V}, \mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=35 \mathrm{pF}$ | Room Full |  | 23 | $\begin{aligned} & 48 \\ & 52 \end{aligned}$ | ns |
| Turn-Off Time | $\mathrm{t}_{\text {OFF }}$ |  | $\begin{gathered} \text { Room } \\ \text { Full } \end{gathered}$ |  | 8 | $\begin{aligned} & 33 \\ & 35 \end{aligned}$ |  |
| Break-Before-Make Time | $\mathrm{t}_{\mathrm{d}}$ |  | Full | 1 |  |  |  |
| Charge Injection ${ }^{\text {d }}$ | $\mathrm{Q}_{\text {INJ }}$ | $\mathrm{C}_{\mathrm{L}}=1 \mathrm{nF}, \mathrm{V}_{\mathrm{GEN}}=0 \mathrm{~V}, \mathrm{R}_{\mathrm{GEN}}=0 \Omega$ | Room |  | 79 |  | pC |
| Off-Isolation ${ }^{\text {d }}$ | OIRR | $\mathrm{R}_{\mathrm{L}}=50 \Omega, \mathrm{C}_{\mathrm{L}}=5 \mathrm{pF}, \mathrm{f}=1 \mathrm{MHz}$ | Room |  | -81 |  | dB |
| Crosstalk ${ }^{\text {d }}$ | $\mathrm{X}_{\text {TALK }}$ |  | Room |  | -82 |  |  |
| Source-Off Capacitance ${ }^{\text {d }}$ | $\mathrm{C}_{\mathrm{NO} \text { (off) }}$ | $\mathrm{V}_{\mathrm{IN}}=0$ or $\mathrm{V}+, \mathrm{f}=1 \mathrm{MHz}$ | Room |  | 14 |  | pF |
|  | $\mathrm{C}_{\mathrm{NC} \text { (off) }}$ |  | Room |  | 14 |  |  |
| Channel-On Capacitance ${ }^{\text {d }}$ | $\mathrm{C}_{\mathrm{NO} \text { (on) }}$ |  | Room |  | 48 |  |  |
|  | $\mathrm{C}_{\mathrm{NC} \text { (on }}$ |  | Room |  | 44 |  |  |
| Power Supply |  |  |  |  |  |  |  |
| Power Supply Range | V+ |  |  | 1.8 |  | 5.5 | V |
| Power Supply Current | I+ | $\mathrm{V}_{\text {IN }}=0$ or $\mathrm{V}_{+}$ | Full |  | 0.01 | 1.0 | $\mu \mathrm{A}$ |

Notes:
a. Room $=25^{\circ} \mathrm{C}$, Full $=$ as determined by the operating suffix.
b. Typical values are for design aid only, not guaranteed nor subject to production testing.
c. The algebraic convention whereby the most negative value is a minimum and the most positive a maximum, is used in this data sheet.
d. Guarantee by design, nor subjected to production test.
e. $\mathrm{V}_{\mathrm{IN}}=$ input voltage to perform proper function.
f. Guaranteed by 5 V leakage testing, not production tested.

[^0]TYPICAL CHARACTERISTICS $25^{\circ} \mathrm{C}$, unless otherwise noted


TYPICAL CHARACTERISTICS $25^{\circ} \mathrm{C}$, unless otherwise noted


Switching Time vs. Temperature


Switching Threshold vs. Supply Voltage

## TEST CIRCUITS



$$
\mathrm{v}_{\mathrm{OUT}}=\mathrm{v}_{\mathrm{COM}}\left(\frac{\mathrm{R}_{\mathrm{L}}}{\mathrm{R}_{\mathrm{L}}+\mathrm{R}_{\mathrm{ON}}}\right)
$$




Charge Injection vs. Analog Voltage

[^1]Figure 1. Switching Time

## TEST CIRCUITS



Figure 2. Break-Before-Make Interval


IN depends on switch configuration: input polarity determined by sense of switch.
Figure 3. Charge Injection


Figure 4. Off-Isolation


Figure 5. Channel Off/On Capacitance

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[^1]:    Logic "1" = Switch On
    Logic input waveforms inverted for switches that have the opposite logic sense.

